Composite substrate material for SAW Sensor

Sean Wu¹ and Yeong-Chin Chen¹ and Maw-Shung Lee²

1. Department of Electronics Engineering, Tung-Fung Institute of Technology, 110 Tung-Fung Road, Hunei Shiang, Kaohsiung 829, Taiwan, R.O.C.
2. Department of Electronics Engineering, National Kaohsiung University of Applied Sciences, Kaohsiung, Taiwan, R.O.C.

Abstract

Surface acoustic wave (SAW) sensor is an important role of the acoustic wave (AW) sensors. Two-port SAW delay line is the primary device of SAW sensor and two-port delay line-based oscillator is a measurement technology for SAW sensor. Y-128° LiNbO₃ is a well-known high-electromechanical-coupling substrates for SAW sensor, but its usefulness is limited because of its poor temperature-stability property. AlN films have some excellent characteristics, such as high SAW velocity, stable chemical properties, and high-temperature stability. In this research, the c-axis-oriented AlN films were sputtered on Y-128° LiNbO₃ to be a new composite substrate, the films quantity was measured by X-ray and Atomic Force Microscope (AFM) methods. We make a two-port SAW delay line device (wavelength is 100 μm) and two-port delay line-based oscillator for sensor measurement circuits. Compared with the original Y-128° LiNbO₃ substrate, the properties of the sensor oscillator using the composite substrate were study in the research.

After measuring, X-ray and AFM figures exhibited the deposited films is well c-axis-oriented AlN films. The AlN film-thickness is 4.51 μm. For the composite substrate (AlN/Y-128° LiNbO₃), the sensor oscillator frequency at 15°C also increased from 40.1209 MHz up to 42.0103 MHz and the temperature coefficient of frequency (TCF) value of sensor oscillator was from −76.32 (ppm/°C) to −28.21 ppm/°C. It exhibited the composite substrate (AlN/Y-128° LiNbO₃) will enhance the sensor oscillator frequency and effectively improve the poor temperature stability. That composite substrate is good for the applications on SAW sensor.